



An ERDM Search with SuperCDMS HVeV Detectors at SNOLAB

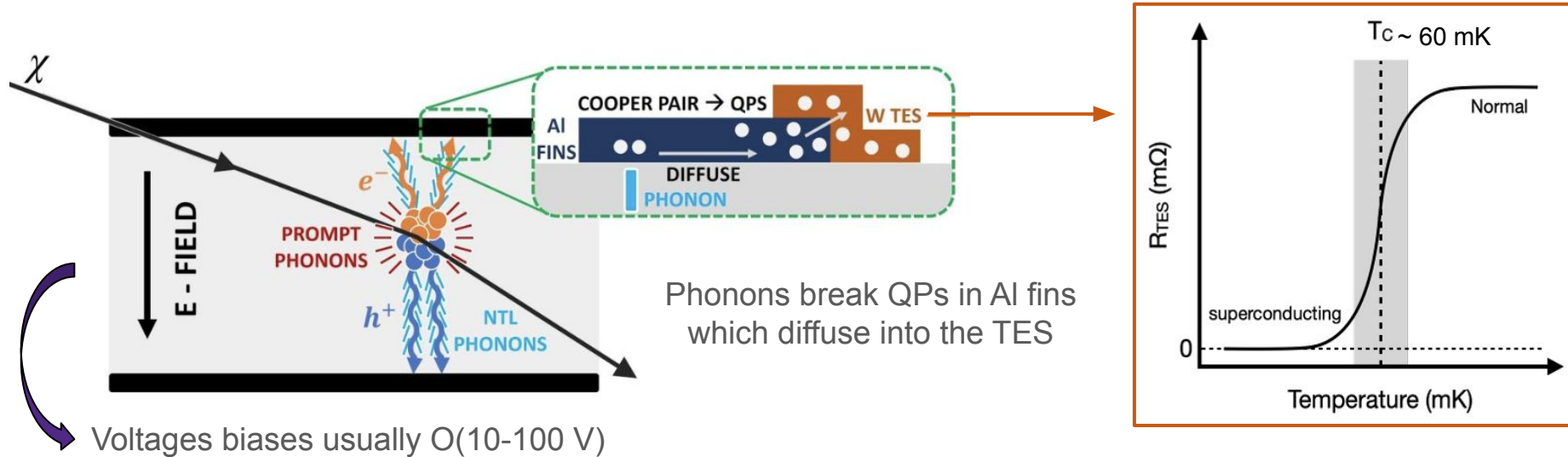
Kyle Kennard
on behalf of the SuperCDMS Collaboration

The SuperCDMS Collaboration



Searching for **sub-GeV dark matter** via direct detection
Need detectors with excellent energy resolution

Detector Schematic



DM interacts with cold crystal

Generates phonons and charge carriers



Freed charges accelerated by E-Field

Charges emit more phonons

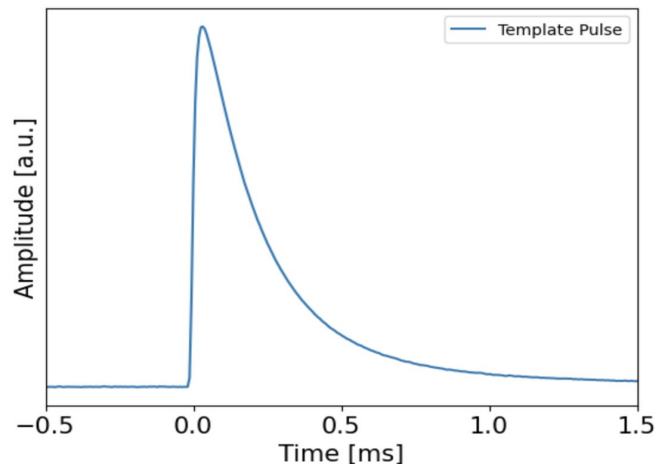


Total Phonon Energy

$$E = E_R + n_{eh}eV$$

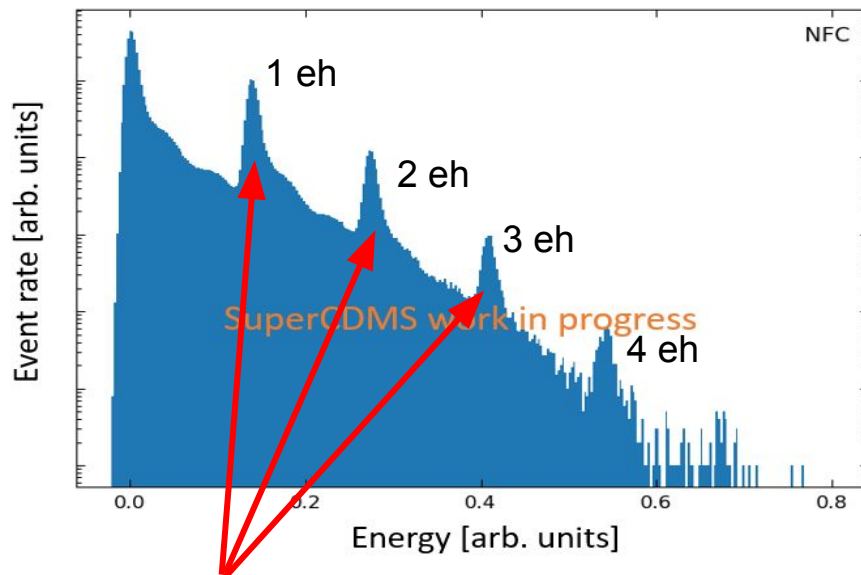
Expected Response

Response from Particle Interaction



Height of pulse gives
estimate of energy

Example Energy Spectrum



Peaks correspond to number of
electron-hole (eh) pairs produced

The HVeV Program — SuperCDMS R&D

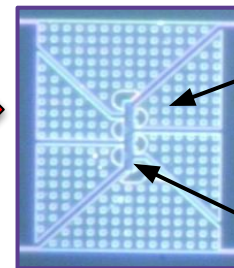
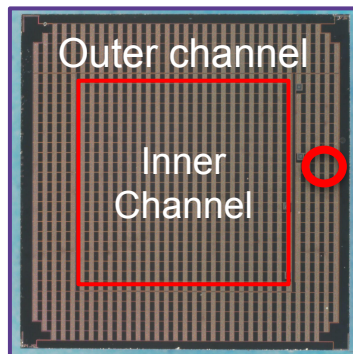
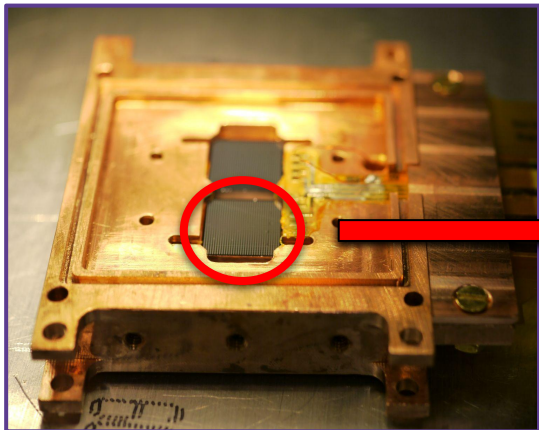
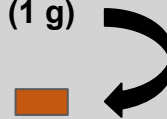
Uses gram-scale detectors aimed at achieving eV-scale energy resolution for:

- Background classification
- Charge-transport studies
- **Low-mass DM searches**

Size Comparison to a SuperCDMS HV Detector

Si HV Detector
(610 g)

Si HVeV Detector
(1 g)



Al fins act as
phonon “funnels”

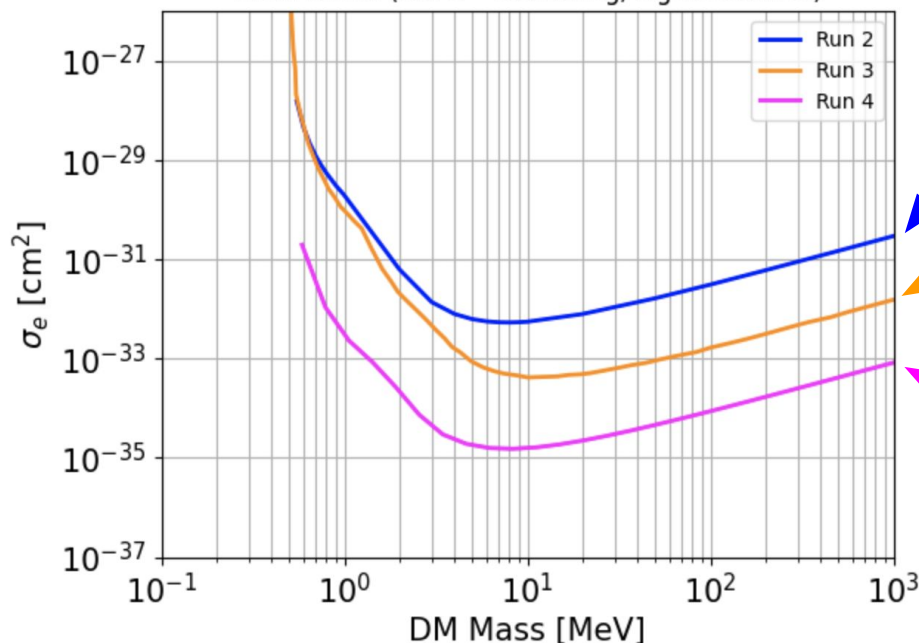
Tungsten TES

HVeVs as a Maturing Technology

HVeVs are a relatively new technology

~5 years of studying backgrounds and operation techniques have yielded improvement

HVeV Limits (DM- e^- Scattering, Light Mediator)



2019: Search at surface facility
~3.5 eV Resolution

2021: Search at NEXUS
Coincidence rejection
Overburden
~3 eV Resolution

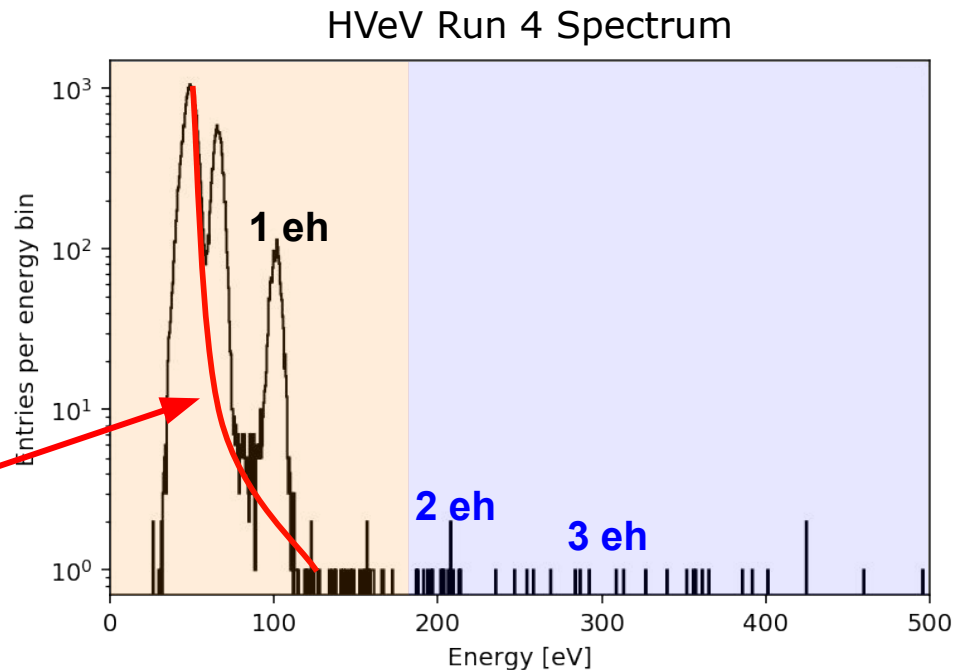
2022: Search at NEXUS
Improved housings using low bkg
materials
~2.5 eV Resolution

The Next Generation of Improvement

Want to improve on the latest search— HVeV Run 4:

- Run 4 improved by mitigating **high energy backgrounds (2+ eh)**
- We are now limited by **low energy backgrounds!**
 - 1 eh Rate
 - Low Energy Excess (LEE)

Need to understand these new limiting backgrounds



Detector Payload

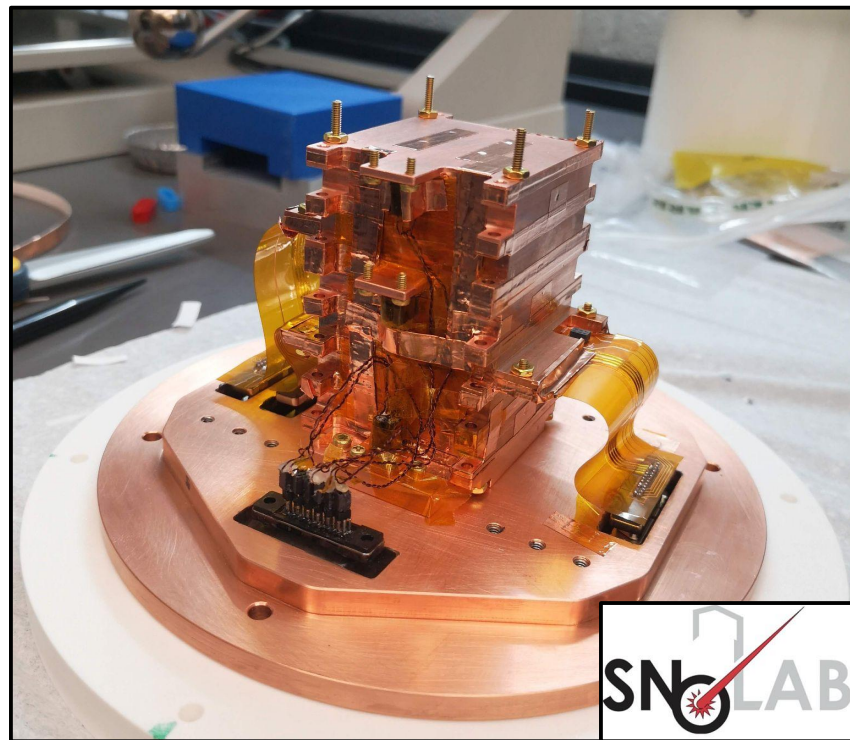
Operated in dilution fridge (~ 14 mK) at the CUTE facility in SNOLAB

- $\sim 100,000\times$ lower muon flux than NEXUS!
- Payload of six HVeV detectors
 - R4 detectors
 - Two new detectors
- LEDs for calibration

Primary Goal:

Study the Low Energy Excess (LEE)

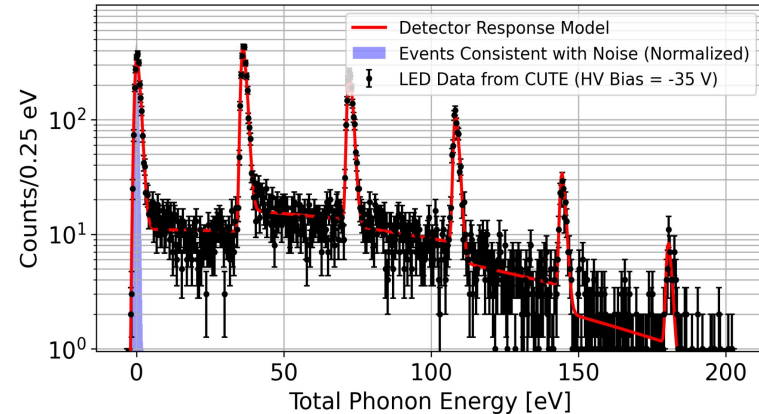
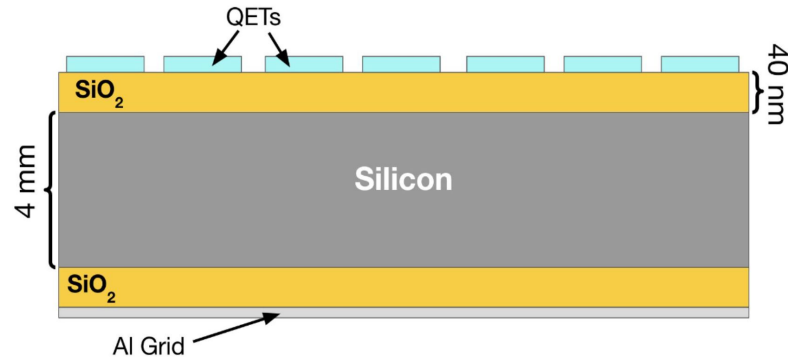
Performed an ERDM search when we realized we had low backgrounds



The Next Generation HVeV

ERDM search used data from a single, new HVeV detector

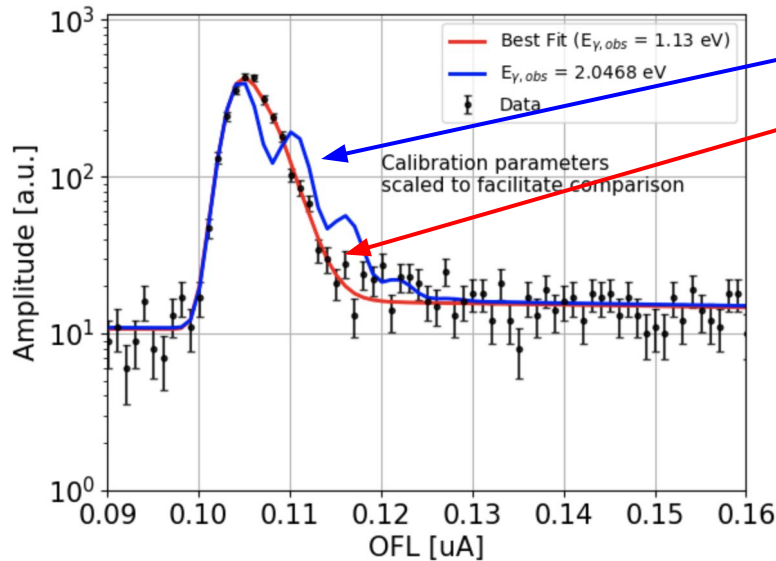
- Has lower T_C TESs for better resolution
- Included an SiO_2 layer to prevent leakage from Al films into the substrate



Calibrated with ~ 2 eV photons $\rightarrow$ **Achieved a 589 meV resolution**
New personal best for HVeVs!

Energy Loss Mechanism

- Structure in eh peaks is complicated by **surface-trapped events**: In a surface-trapped event, eh pairs recombine near surface and don't yield NTL energy
- Gives peaks an underlying Poisson distribution



Model with full energy collection

Best fit says we lose ~ 0.9 eV per photon

Consider three scenarios of E_{Loss} for DM Limits:

1. No energy loss
2. A constant loss per eh pair produced
3. A percentage loss of the initial recoil energy

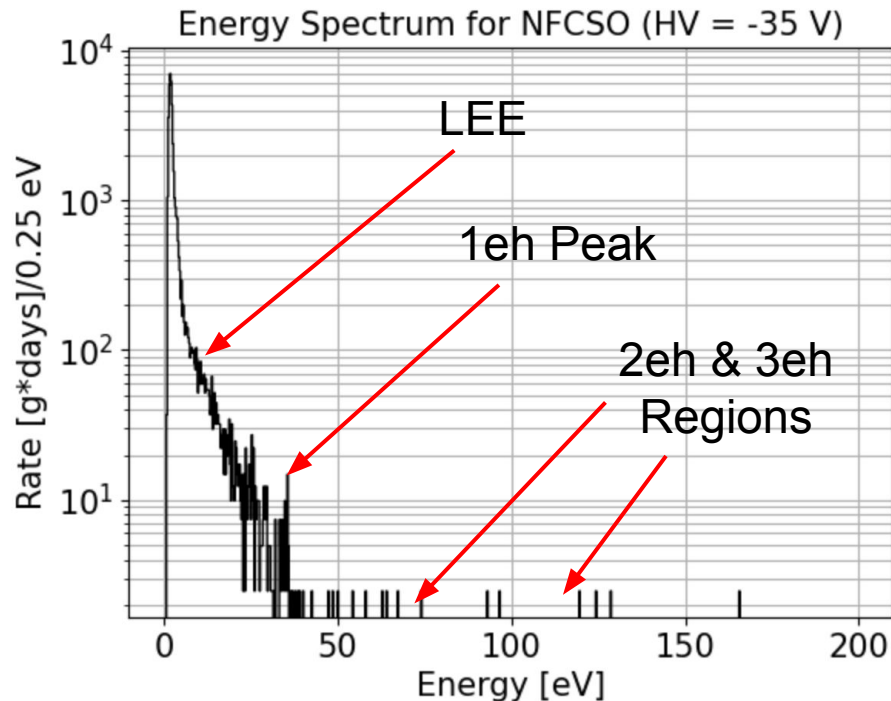
Electron-Recoil DM Search

- Taking DM search data at -35 V bias
 - ~13 days of exposure
 - 90% of data is blinded

Reduced 1eh rate compared to previous measurements

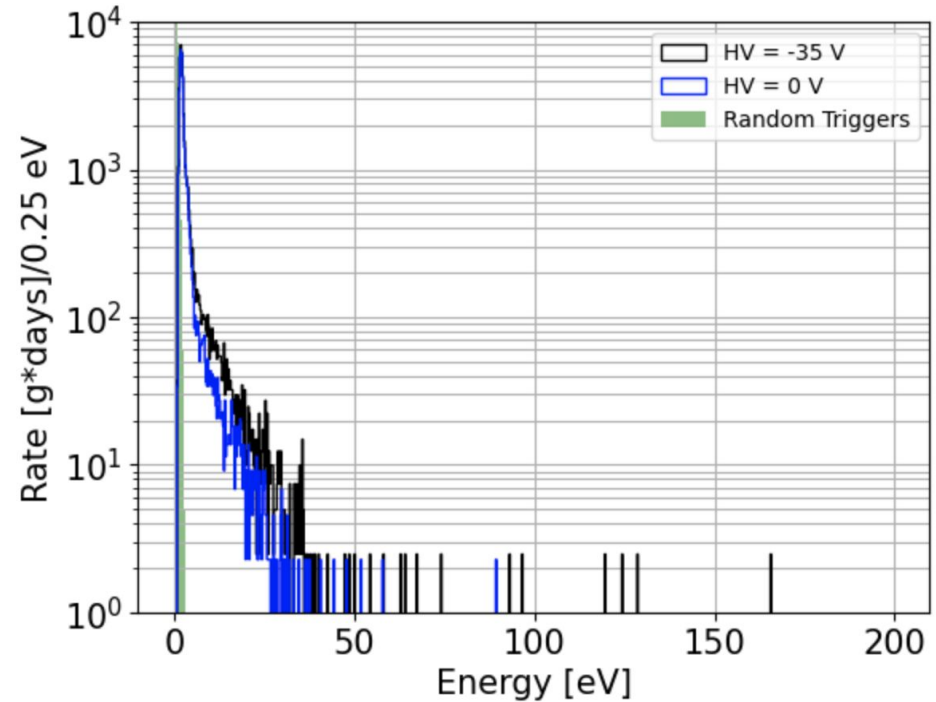
- 1eh Peak has a rate similar to the surrounding LEE
- Other experiments have found that the LEE is primarily non-ionizing...

~10 Hours of Live Time



Non-ionizing Background

- ... We can see that by comparing to data taken with 0 V bias



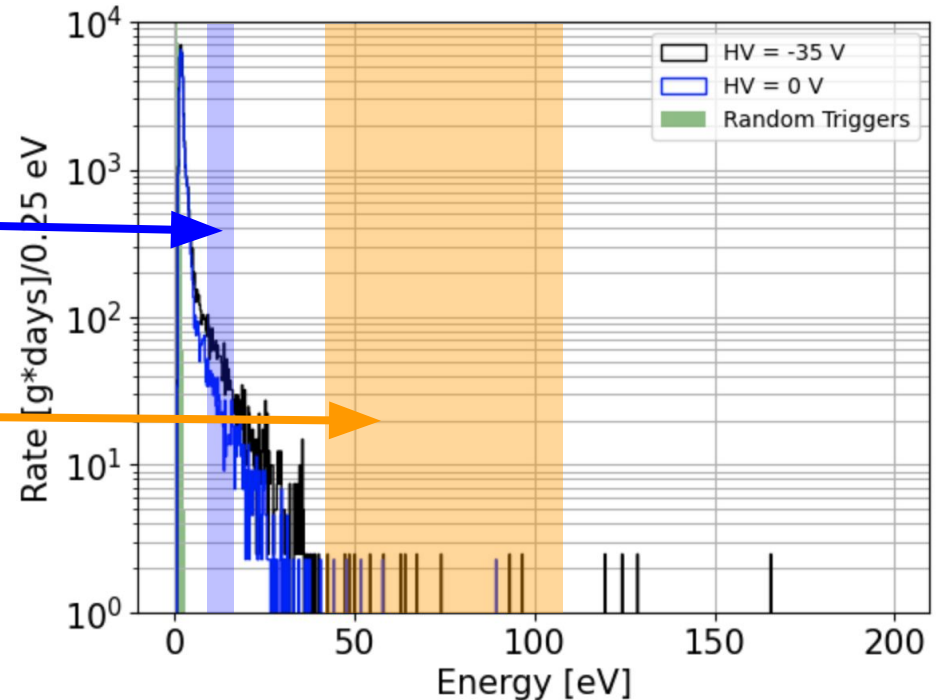
Non-ionizing Background

If the 0V background were ionizing,
then **0V events from here...**

- ~900 events/g*day in 0V

...Would appear **somewhere here with HV on.**

- ~30 events/g*day in HV

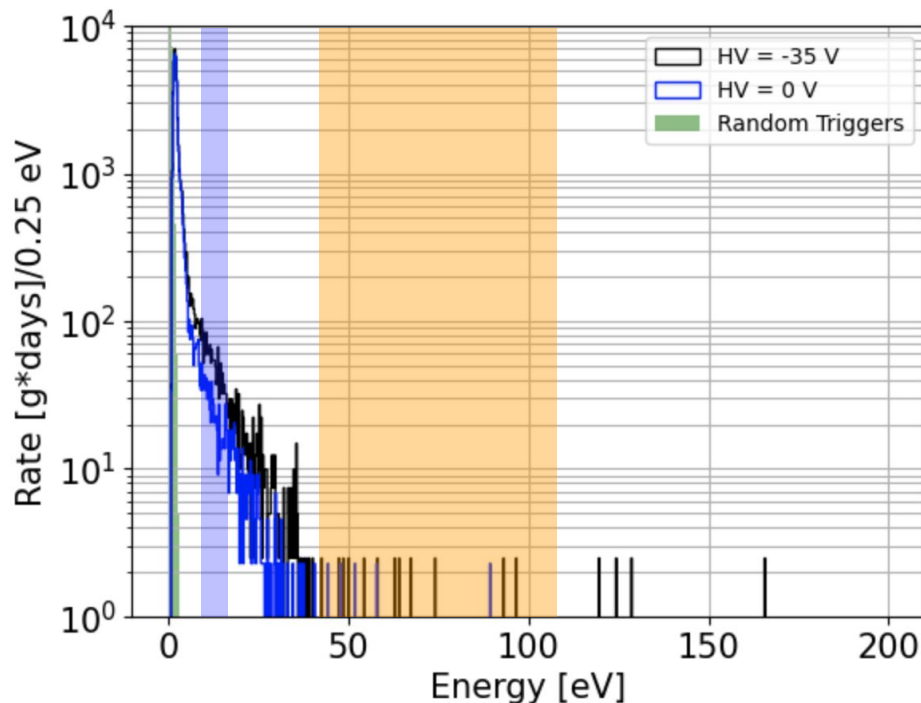


Non-ionizing Background

But, in HV data, we only see a small number of events in the **orange region**.

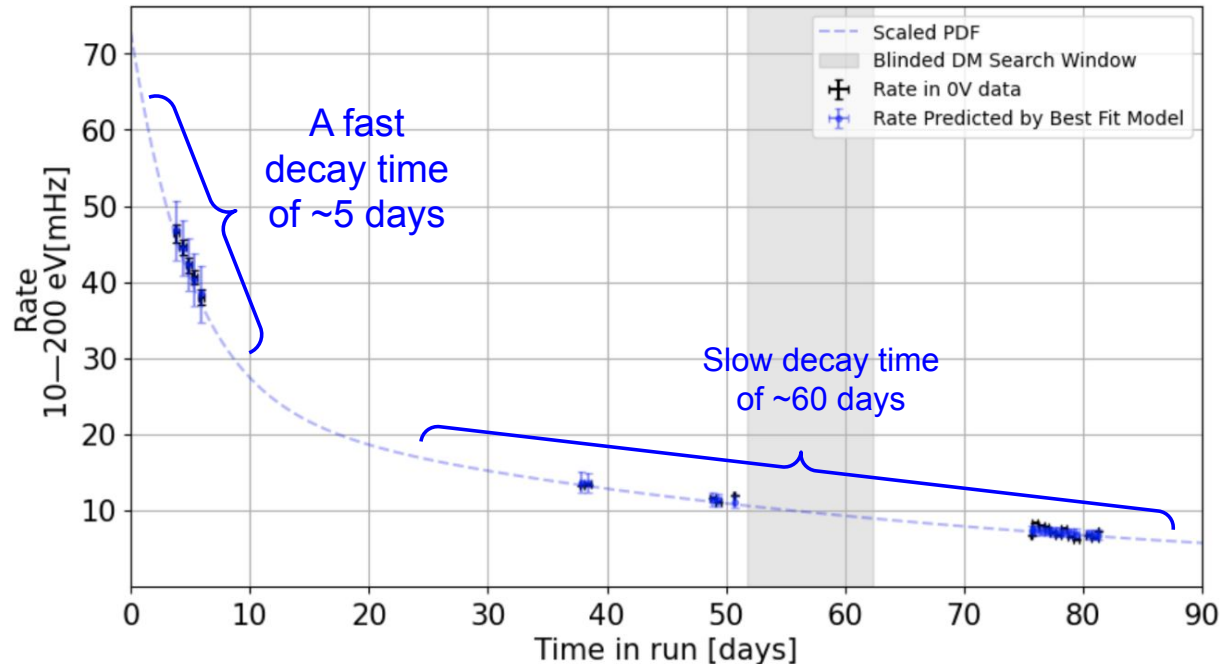
→ **0V** is mostly non-ionizing

Want to account for non-ionizing background in DM Search!



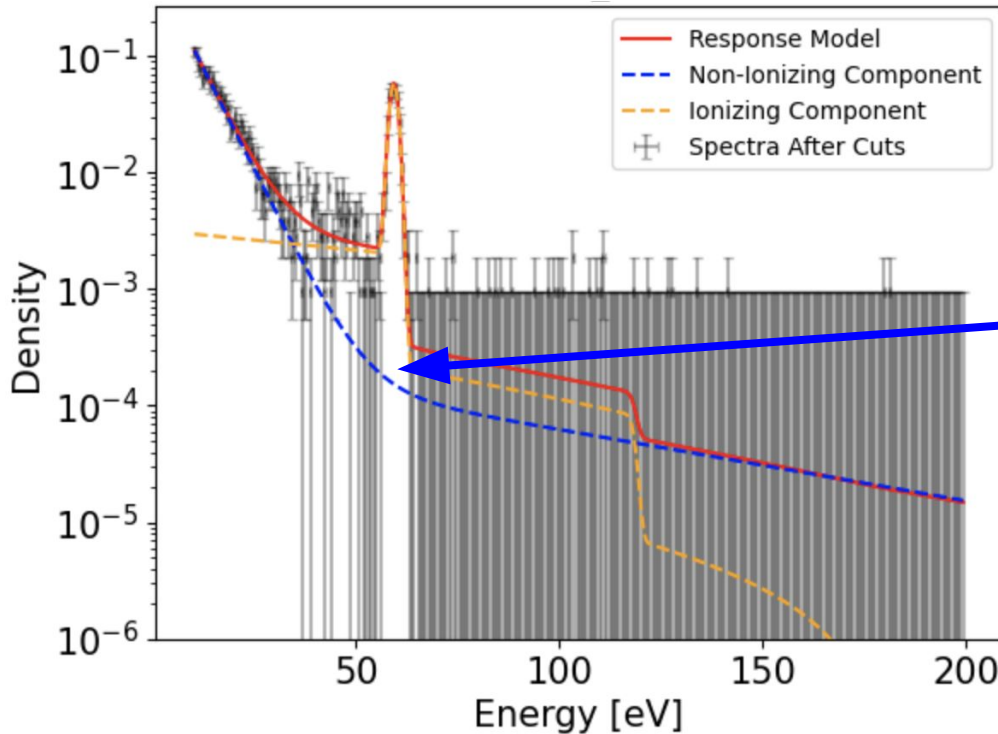
Non-ionizing Background

- Shape of 0V spectrum remains constant with time
- **Rate of 0V background changes with time**



Non-ionizing Background

HV data taken at 60 V

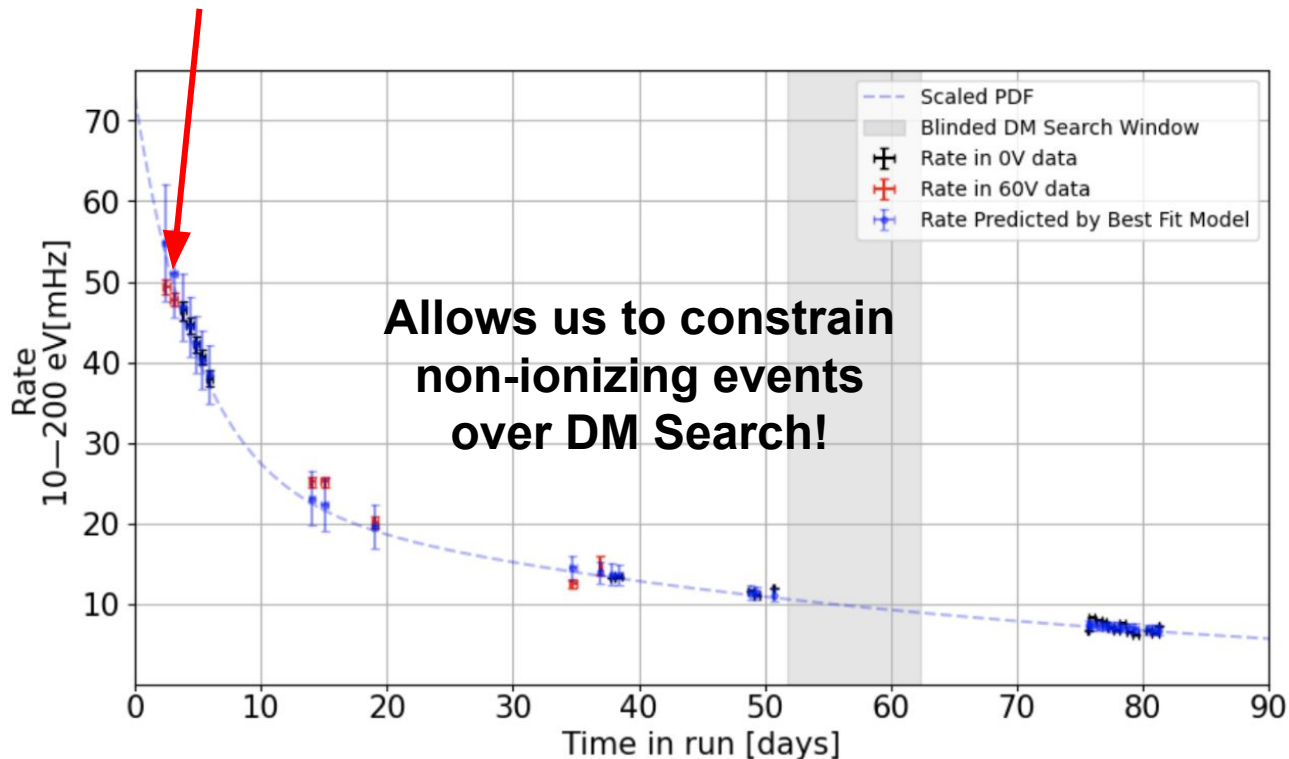


Model HV spectra with a **non-ionizing component**

Extract rate of the non-ionizing component in HV data

Non-ionizing Background

- **Non-ionizing rate from fits to HV data** matches rate measured from 0V!



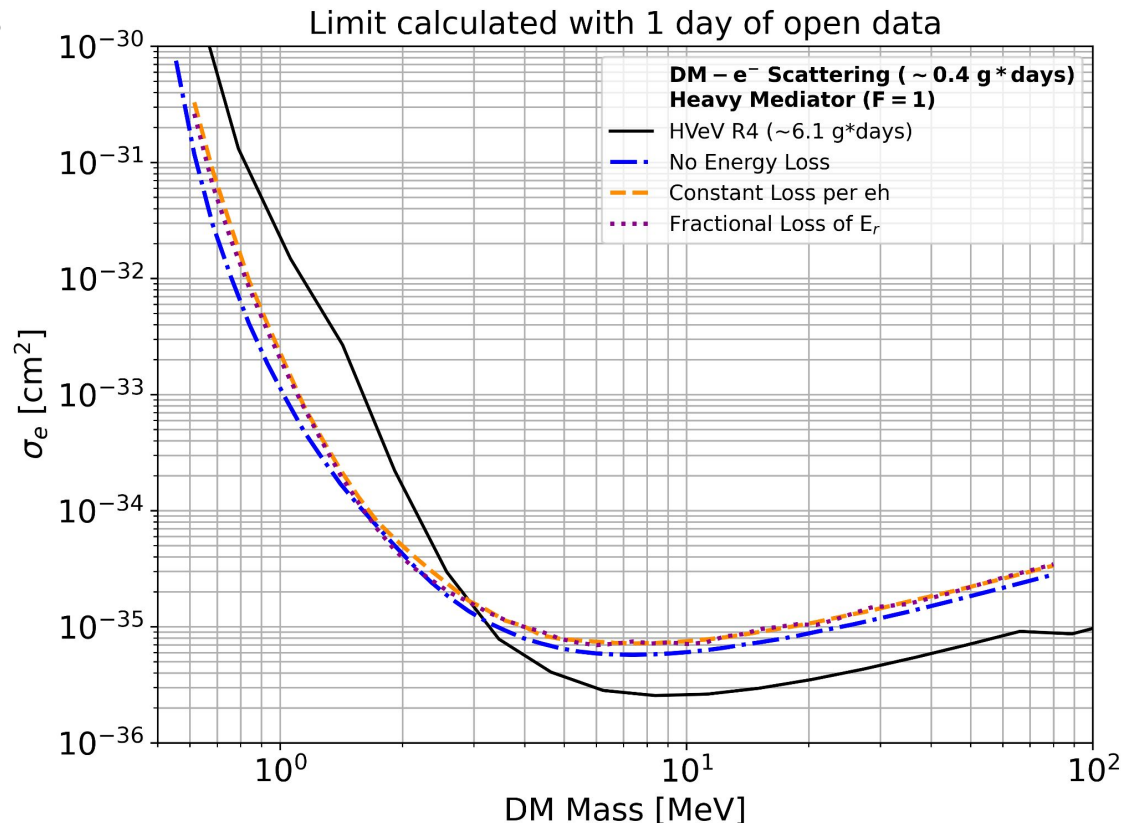
Preliminary Limits

Full unblinded limits currently in progress
Currently showing 1 day of data

Calc limit under three scenarios:

1. No energy loss
2. Constant loss per eh
3. Percent loss of recoil E

Poised for another factor of ~ 10
improvement over Run 4!



Preliminary Limits

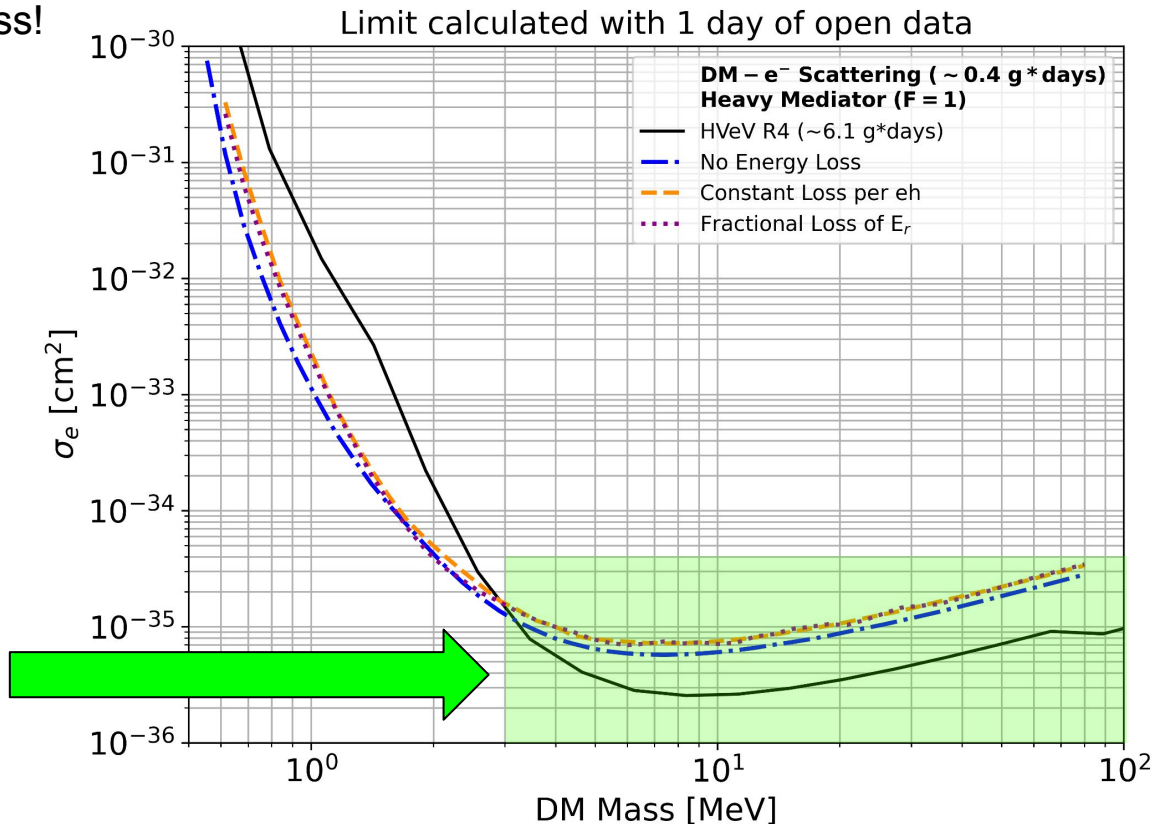
Full unblinded limits currently in progress!
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Calc limit under three scenarios:

1. No energy loss
2. Constant loss per eh
3. Percent loss of recoil E

Poised for another factor of ~ 10
improvement over Run 4!

Expect limits to improve for higher
masses after unblinding

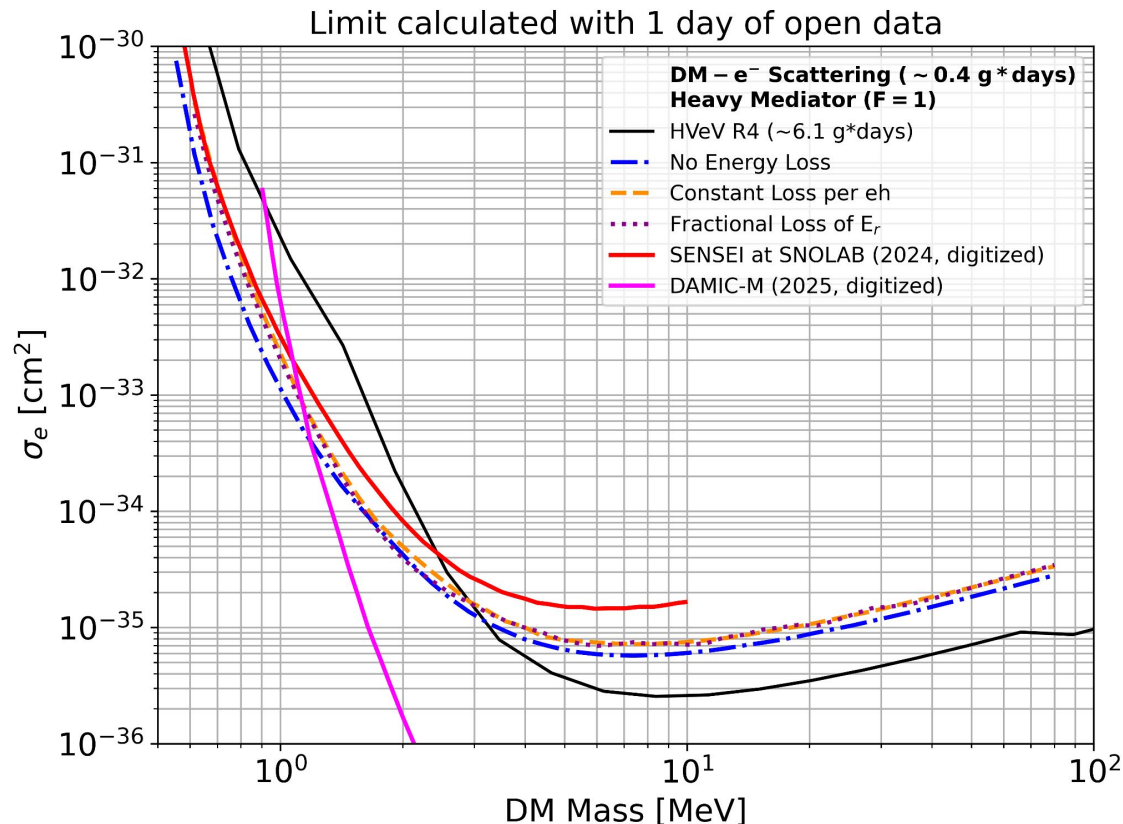


Preliminary Limits

In the most conservative case:

- **World leading below ~ 1.2 MeV**
- Competing with dark matter dedicated experiments, **SENSEI & DAMIC-M**

This is with only 1 day of data



Conclusion



- SuperCDMS has been improving HVeVs steadily over the past ~5 years
- HVeVs are now competing with the most sensitive DM-dedicated experiments in the field!

World leading below ~1.2 MeV!

- Unblinding currently in progress
Stay tuned for final results
- More HVeV developments on the way
 - Position reconstruction
 - Studies of the LEE
 - And more!

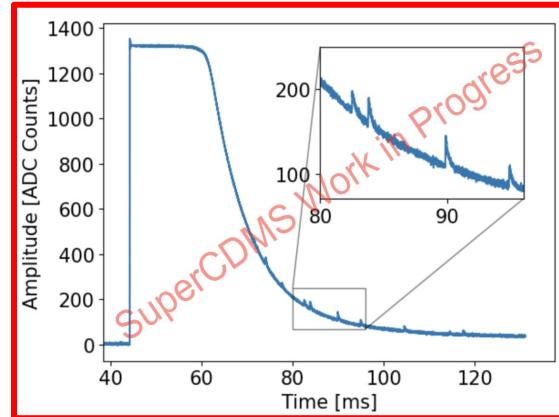
Bonus Slides

Pesky Background: “Burst Events”

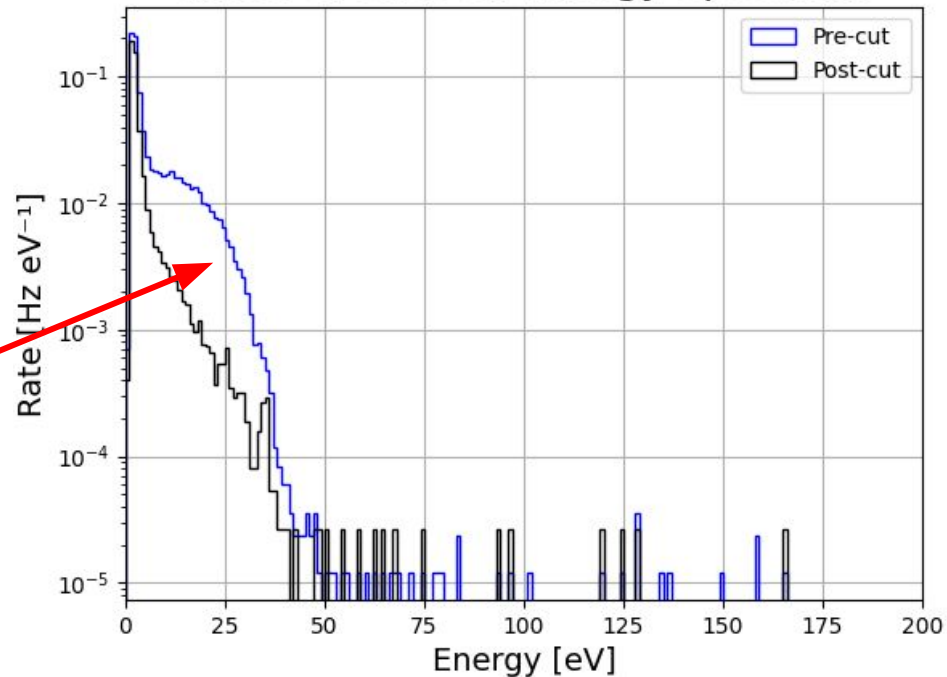
We see “bursts” of low energy events occurring after some high energy events

Trigger Rate can jump by a factor up to ~ 100 during a burst!

We believe these explain the difference between 0V and HV events data!

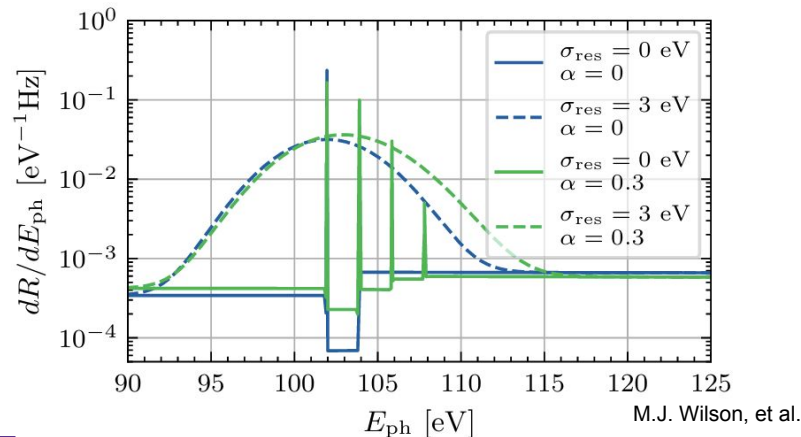
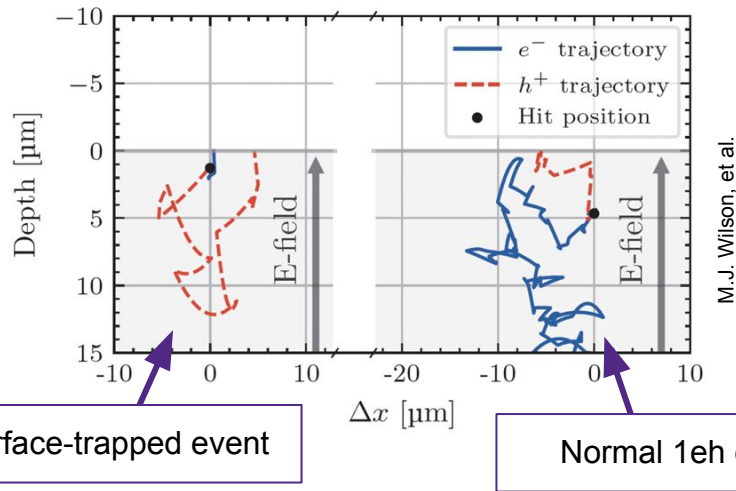


Effect of Cuts on Energy Spectrum



Surface-Trapping: Structure in eh Peaks

PhysRevD.109.112018



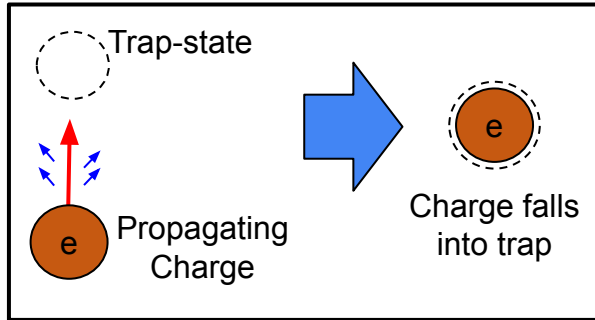
- Simulations show a possible surface-trapping (ST) effect
- ST events don't yield any NTL energy but only give the photon energy
 - Underlying Poisson structure in eh peaks!
- In R4, $\sigma_{\text{res}} \sim E_{\gamma}$ so ST manifests as broadening and shifting of eh peaks

Charge-Trapping & Impact Ionization

Events that can happen on a charge's journey through the crystal...

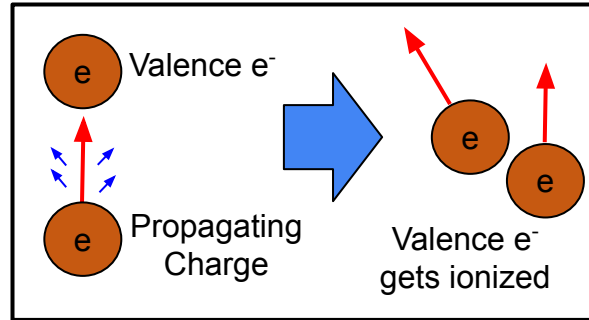
Charge-Trapping

- Propagating charge falls into a trap state
- Gain back a portion of recombination energy
- Lose NTL energy



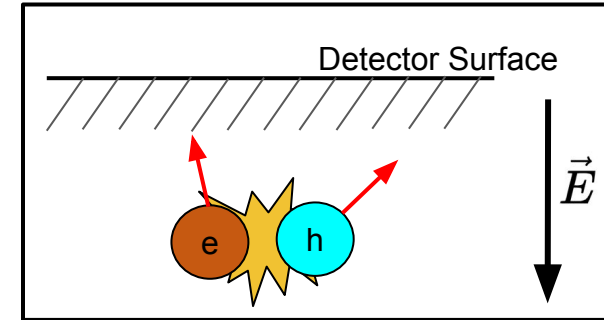
Impact-Ionization

- Propagating charge scatters off electron and ionizes it
- Gain NTL energy



Surface Trapping

- Charges recombine on surface instead of propagating through E-Field
- Lose ~100% of NTL energy



Reducing Backgrounds — HVeV Run 4

Dark Matter Search at the **N**orthwestern **E**xperimental **U**nderground **S**ite (225 m.w.e)

Boxes with LEDs (used for calibration)

New light-tight copper housings!

- Attempt to reduce IR backgrounds
- Avoids scintillating materials

